Fast Recovery Diode

June, 2011

#### **General Description**

FRD that has excellent high speed performance is incorporated into the TO-3PF at high current package. It achieved a balance between high speed at high temperature operates and low-VF.

### **Applications**

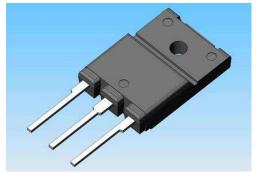
- · A DC-DC converters.
- · A high current secondary rectifier.
- A high frequencies rectifier circuit, etc.

### **Features**

- · An ultrafast recovery diode.
- A balance low-VF and high speed performance at high temperature.
- A great radiation performance due to high-current package.
- A great isolation performance due to full mold package.

### Package

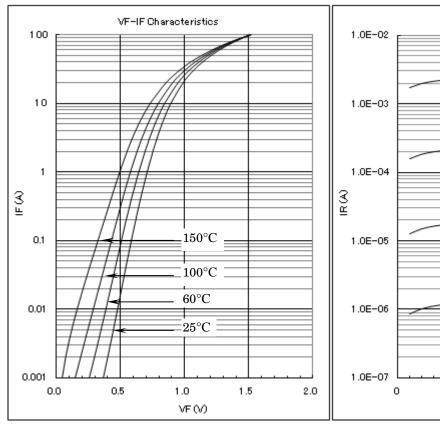
(TO-3PF 3pin)

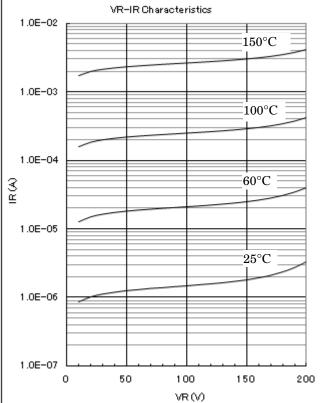


**Key Specifications** 

Item	Unit	Rating	Conditions
$V_{RM}$	V	200	
$V_{\mathrm{F}}$	V	1.05	$I_F=10A$
$I_{F(AV)}$	A	20	
t <sub>rr</sub>	ns	30	

### Typical Characteristics





VF-IF&VR-IR show ratings per one chip.

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## **★** Absolute maximum ratings

No.	Item	Symbol	Unit	Rating	Conditions
1	Transient Peak Reverse Voltage	$V_{ m RSM}$	V	200	
2	Peak Reverse Voltage	$V_{ m RM}$	V	200	
3	Average Forward Current	$I_{F(AV)}$	A	20	
4	Peak Surge Forward Current	I <sub>FSM</sub>	A	150	10msec. Half sinewave, one shot
5	I <sup>2</sup> t Limiting Value	${ m I}^2{ m t}$	$ m A^2s$	112.5	$1$ msec $\leq$ t $\leq$ 10msec
6	Junction Temperature	$T_{\rm j}$	°C	-40~ +150	
7	Storage Temperature	$\mathrm{T}_{\mathrm{stg}}$	°C	-40~ +150	

No.1,2,4&5 show ratings per one chip.

# **★** Electrical characteristics (Ta=25°C, unless otherwise specified)

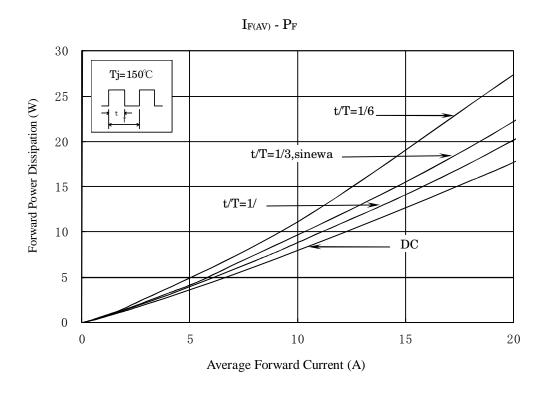
No.	Item	Symbol	Unit	Value	Conditions
1	Forward Voltage Drop	$ m V_F$	V	1.05 max.	I <sub>F</sub> =10A
2	Reverse Leakage Current	$I_R$	uA	50 max.	$V_R = V_{RM}$
3	Reverse Leakage Current Under High Temperature	$H \cdot I_R$	mA	30 max.	V <sub>R</sub> =V <sub>RM</sub> , T <sub>j</sub> =150°C
4	Reverse Recovery Time	trr1	ns	30 max.	$I_F = I_{RP} = 500 \text{mA},$ $T_j = 25^{\circ}\text{C}$ , 90% Recovery point
		trr2	ns	25 max.	I <sub>F</sub> =500mA,I <sub>RP</sub> =1A, T <sub>j</sub> =25°C, 75% Recovery point
5	Thermal Resistance	$R_{\mathrm{th(j-l)}}$	°C/W	2.0 max.	Between Junction and case

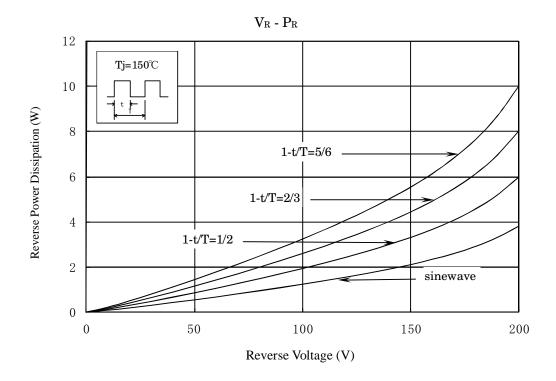
No.1,2,3&4 show characteristics per one chip.

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### \* Characteristics





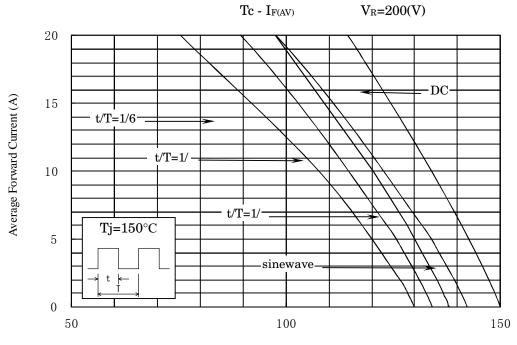
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## \* Derating



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## **★** Package information (**mm**)

